Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/734,541	SHIRAISHI ET AL.	
Examiner	Art Unit	
Minh-Chau T. Pham	1724	

SEARCHED				
Class	Subclass	Date	Examiner	
55	487	5/30/2006	МСР	
55	367	5/30/2006	МСР	
55	498	5/30/2006	МСР	
55	524	5/30/2006	MCP	
55	527	5/30/2006	MCP	
55	528	5/30/2006	MCP	
55	Dig. 25	5/30/2006	MCP	
210	489	5/30/2006	MCP	
210	496	5/30/2006	MCP	
210	497.1	5/30/2006	МСР	
210	497.2	5/30/2006	МСР	
210	505	5/30/2006	МСР	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
55	487	5/30/2006	МСР		
55	367	5/30/2006	МСР		
210	497.1	5/30/2006	МСР		
(see attachment)		5/30/2006	МСР		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East search for Classes 55 and 210	5/30/2006	МСР
Text search	5/30/2006	МСР
Inventor search	5/30/2006	МСР